

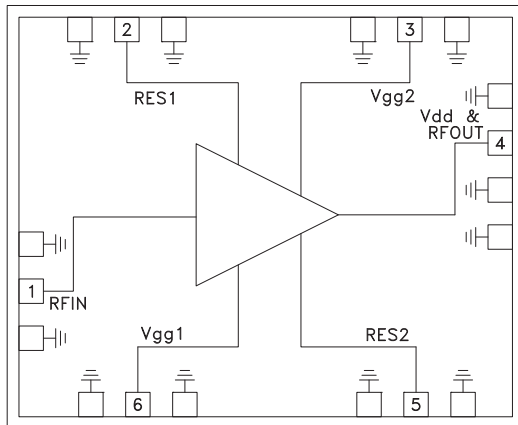
GaAs HEMT MMIC MODULATOR DRIVER AMPLIFIER, DC - 35 GHz

Typical Applications

This HMC-AUH249 is ideal for:

- Fiber Optic Modulator Driver
- Gain Block for Test & Measurement Equipment
- Point-to-Point/ Point-to-Multi-Point Radios
- Wideband Communication & Surveillance Systems
- Radar Warning Systems
- Military & Space

Functional Diagram



Features

- Small Signal Gain: 15 dB
- Output Voltage: up to 8V pk-pk
- Psat Output Power: +23 dBm
- High Speed Performance: >35 GHz 3 dB Bandwidth
- Supply Voltage: +5V @ 200 mA
- Small Die Size: 2.2 x 1.80 x 0.1 mm

General Description

The HMC-AUH249 is a GaAs MMIC HEMT Distributed Driver Amplifier die which operates between DC and 35 GHz and provides a typical 3 dB bandwidth of 37 GHz. The amplifier provides 15 dB of gain and +23 dBm of saturated output power while requiring only 200 mA from a +5V supply. The HMC-AUH249 exhibits very good gain and phase ripple beyond 25 GHz and can output greater than 8V peak-to-peak, making it ideal for use in broadband wireless, fiber optic communication and test equipment applications. The amplifier die occupies less than 4 mm² which facilitates easy integration into Multi-Chip-Modules (MCMs). The HMC-AUH249 requires a bias-tee as well as off-chip blocking components and bypass capacitors for the DC supply lines. Vgg1 adjusts the bias current for the device while Vgg2 adjusts the output gain.

Electrical Specifications ^[1], $T_A = +25^\circ\text{C}$, $V_{dd} = 5V$, $V_{gg2} = 1.5V$

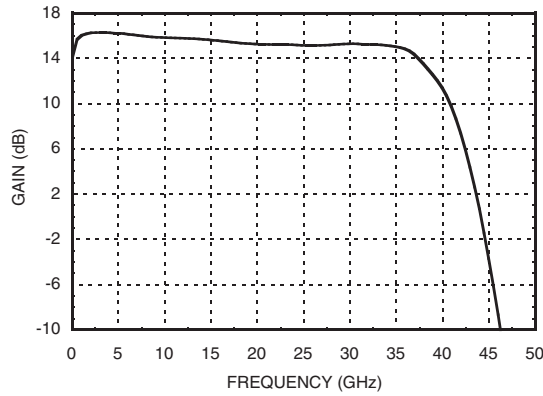
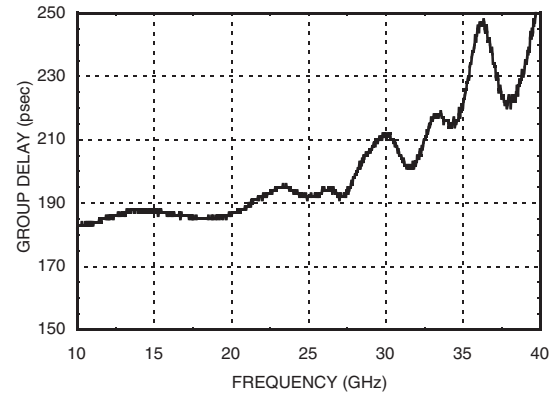
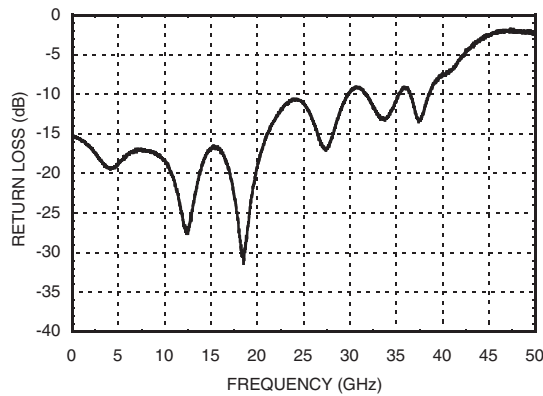
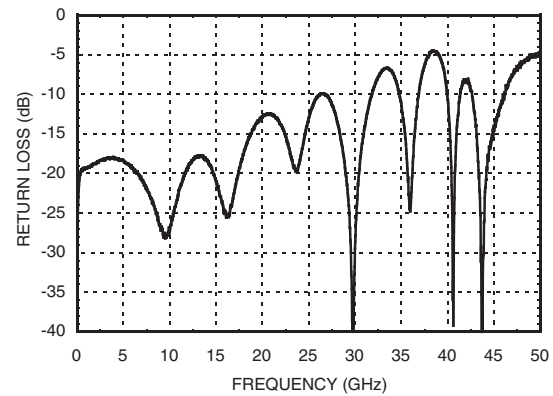
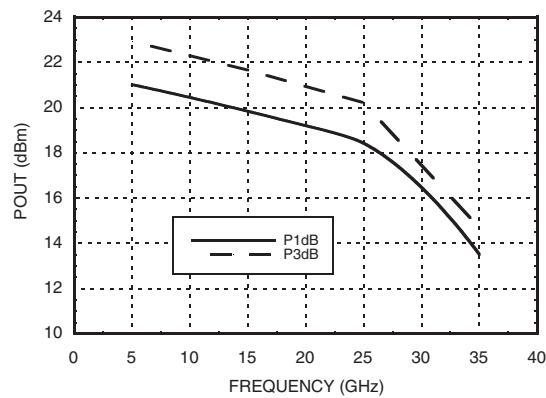
Parameter	Min.	Typ.	Max.	Units
Gain		15		dB
Bandwidth (3 dB)		>35		GHz
Gain Variation	DC - 35 GHz	±1		dB
Group Delay Variation	DC - 25 GHz	±10		ps
Power Output at 1 dB Compression	DC - 5 GHz	21		dBm
Power Output at Saturation	DC - 5 GHz	23		dBm
Maximum Output Amplitude		8		V _{pp}
Input Return Loss	DC - 20 GHz DC - 35 GHz	15 9		dB dB
Output Return Loss	DC - 20 GHz DC - 35 GHz	13 7		dB dB
Power Dissipation		1		W
Supply Current (I _{dd})		200		mA

[1] Unless otherwise indicated, all measurements are from die in a test fixture.

[2] Adjust Vgg1 between -1.0V to 0V to achieve I_{dd} = 200 mA.

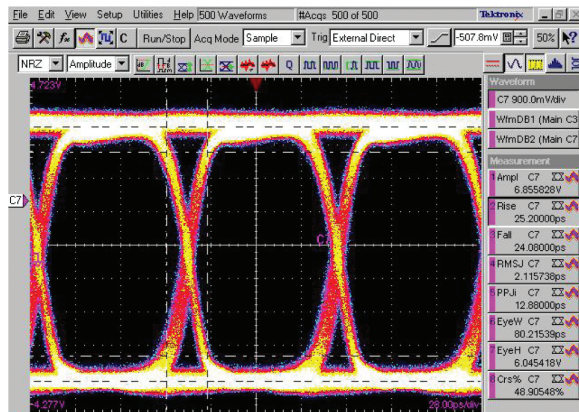
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**GaAs HEMT MMIC MODULATOR
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Gain vs. Frequency

Group Delay vs. Frequency

Input Return Loss vs. Frequency

Output Return Loss vs. Frequency

Fixtured Pout vs. Frequency


GaAs HEMT MMIC MODULATOR DRIVER AMPLIFIER, DC - 35 GHz

12.5 Gb/s Eye Diagram ^[1]



**ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS**

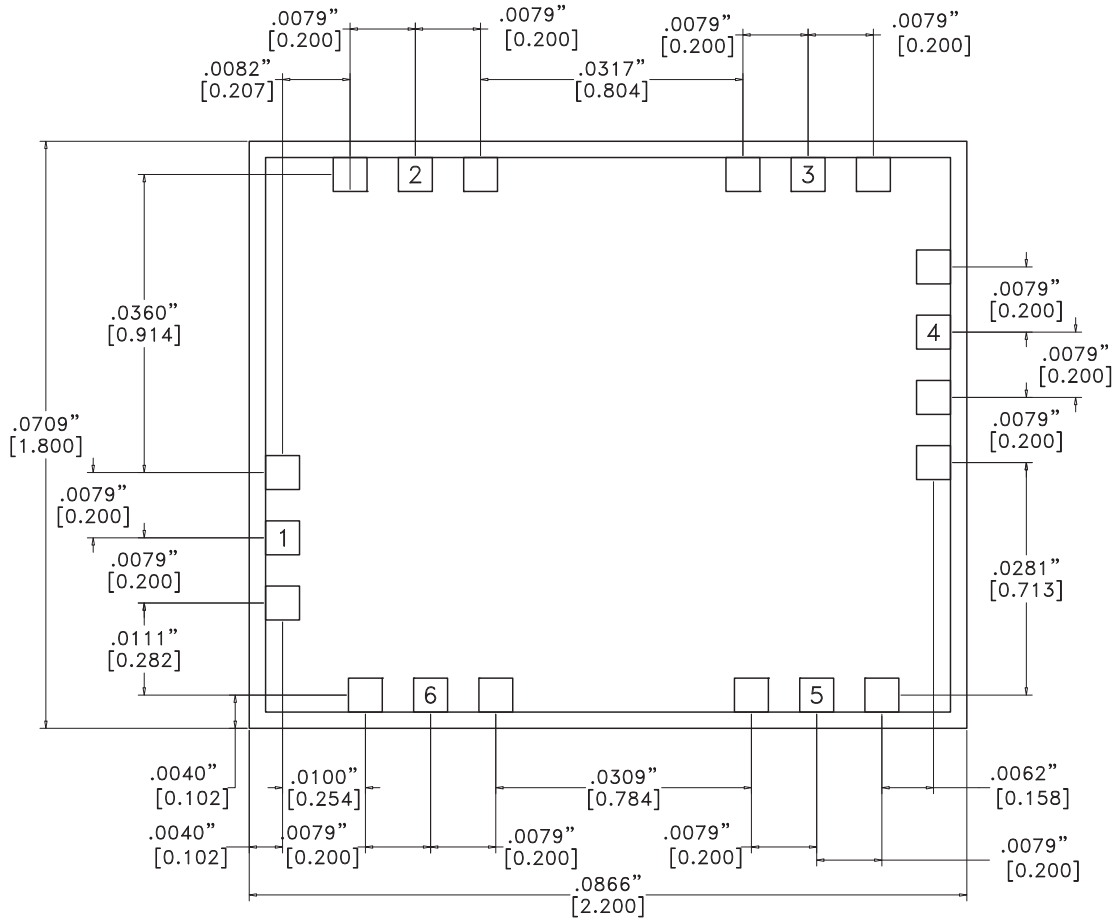
Absolute Maximum Ratings

Drain Bias Voltage (Vdd)	+7 Vdc
RF Input Power	+10 dBm
Channel Temperature	180 °C
Storage Temperature	-65 to +150 °C
Operating Temperature	-55 to +110 °C

Recommended Operating Conditions

Parameter	Min.	Typ.	Max.	Units
Positive Supply Voltage (Vdd)		5	6	V
Positive Supply Current		200	230	mA
Bias Current Adjust (Vgg1)	-1	-0.5	0	V
Output Voltage Adjust (Vgg2)	0.3	1.5	1.5	V
RF Input Power			4	dBm

[1] Input 12.5 Gb/s data stream, 01.0V, PRBS 2³¹-1

**GaAs HEMT MMIC MODULATOR
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Outline Drawing

Die Packaging Information ^[1]

Standard	Alternate
GP-1 (Gel Pack)	[2]

[1] Refer to the "Packaging Information" section for die packaging dimensions.


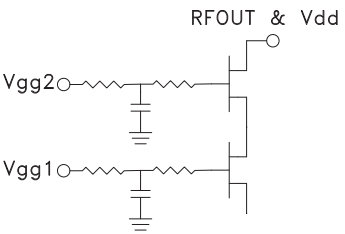


[2] For alternate packaging information contact Hittite Microwave Corporation.

NOTES:

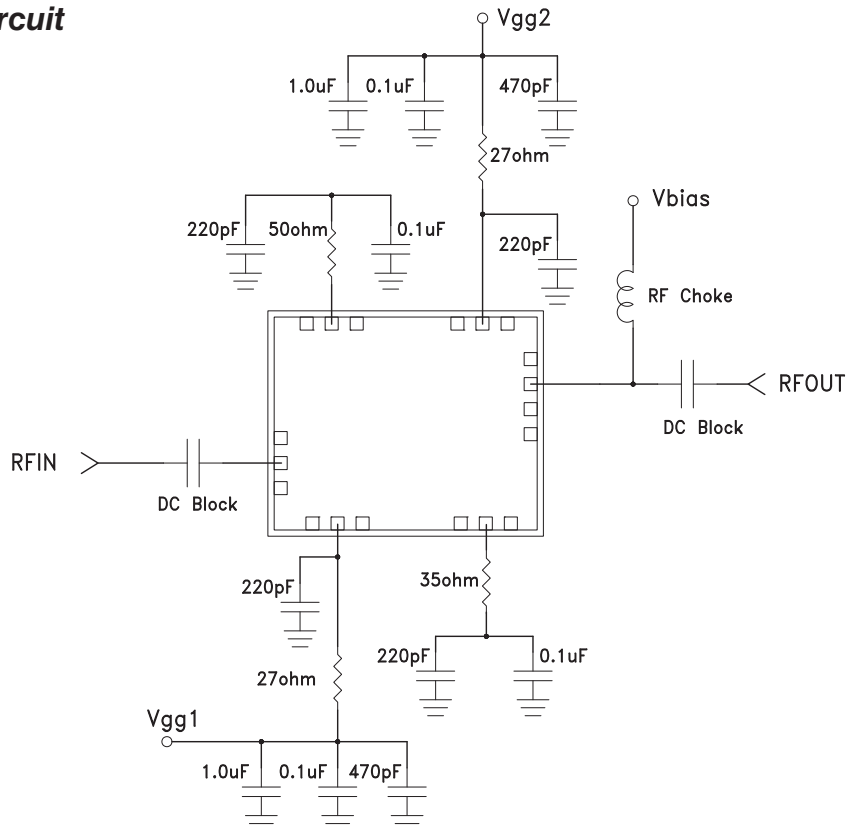
1. ALL DIMENSIONS ARE IN INCHES [MM].
2. TYPICAL BOND PAD IS .004" SQUARE.
3. BACKSIDE METALLIZATION: GOLD.
4. BACKSIDE METAL IS GROUND.
5. BOND PAD METALLIZATION: GOLD.
6. CONNECTION NOT REQUIRED FOR UNLABELED BOND PADS.
7. OVERALL DIE SIZE $\pm .002$ "

GaAs HEMT MMIC MODULATOR DRIVER AMPLIFIER, DC - 35 GHz

Pin Descriptions

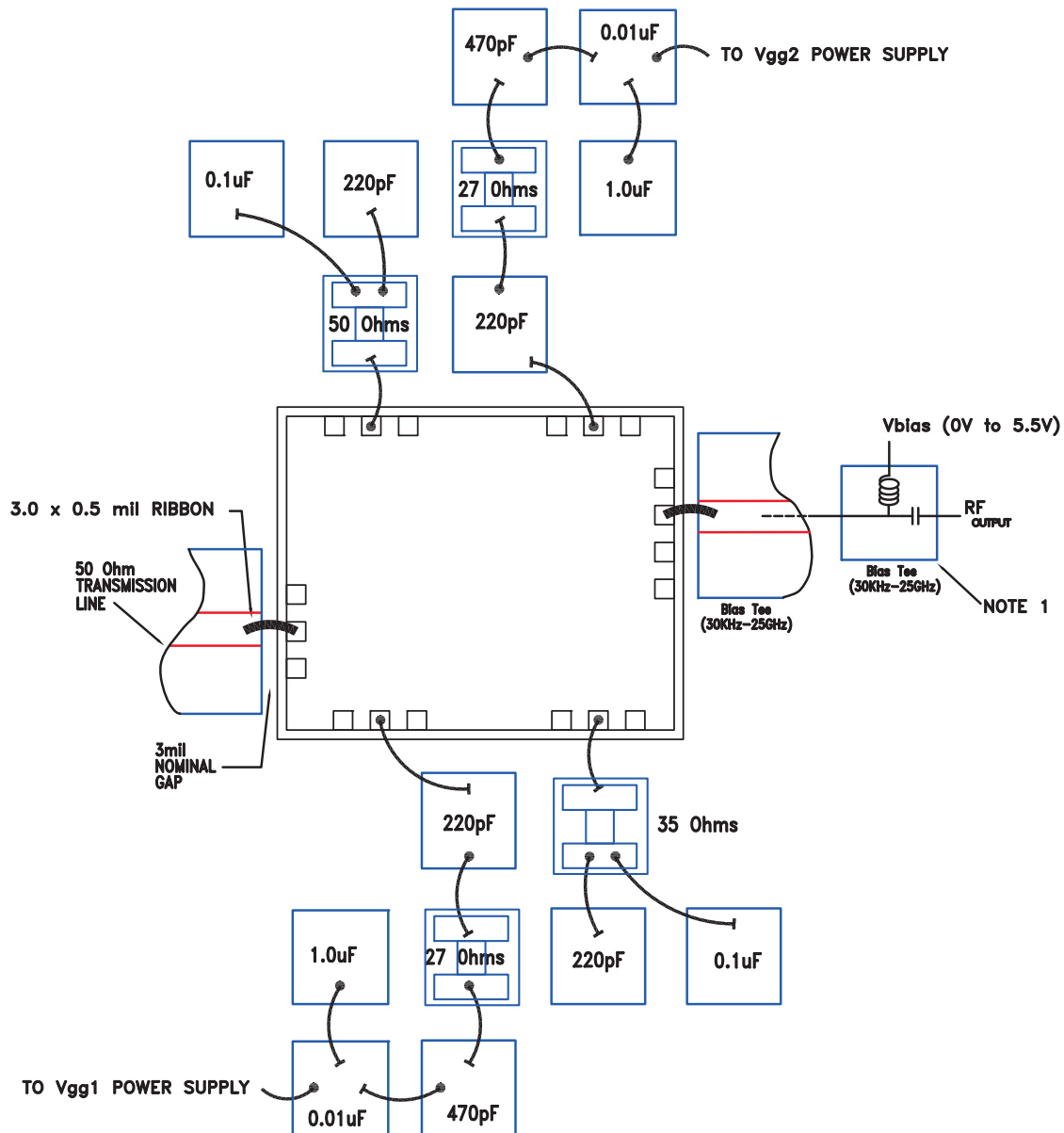
Pin Number	Function	Description	Interface Schematic
1	RFIN	DC coupled. Blocking Cap is needed.	RFIN ○ —
2	RES1	AC coupled 50Ω termination.	
3	Vgg2	Gate control for amplifier. Please follow "MMIC Amplifier Biasing Procedure" application note. See assembly for required external components.	
4	RFOUT & Vdd	RF output and DC bias (Vdd) for the output stage.	
6	Vgg1	Gate control for amplifier. Please follow "MMIC Amplifier Biasing Procedure" application note. See assembly for required external components.	
5	RES2	AC coupled 35Ω termination.	
Die Bottom	GND	Die Bottom must be connected to RF/DC ground.	

Application Circuit



**GaAs HEMT MMIC MODULATOR
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Assembly Diagram



Note 1: Drain Bias (Vdd) must be applied through a broadband bias tee or external bias network

**GaAs HEMT MMIC MODULATOR
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Device Mounting

- 1 mil diameter wire bonds are used on Vgg1 and Vgg2 connections to the capacitors and 27 Ω resistors.
- 0.5mil x 3mil ribbon bonds are used on RF connections
- Capacitors and resistors on Vgg1 and Vgg2 are used to filter low frequency, <800MHz, RF pickup
- 35 Ω and 50 Ω resistors are fabricated on a 5mil alumina substrate and should be suitable for use as a high frequency termination.
- For best gain flatness and group delay variation, eccosorb can be epoxied on the transmission line covering the center 3/4 of the transmission line length. Eccosorb may also be placed partially across the RES1 pad and 35 Ω resistor for improved gain flatness and group delay variation.
(The insertion of the transmission line helps reduce low frequency, <10GHz, gain ripple)
- Silver-filled conductive epoxy is used for die attachment
(Backside of the die should be grounded and the GND pads are connected to the backside metal through Vias)

Device Operation

These devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

The input to this device should be AC-coupled.

Device Power Up Instructions

1. Ground the device
 2. Bring Vgg1 to -0.5V (no Vbias current)
 3. Bring Vgg2 to +1.5V (no Vbias current)
 4. Bring Vdd to +5V (150mA to 225mA drain current)
(Initially the drain current (Vbias) will rise sharply with a small Vbias voltage, but will flatten out as Vbias approaches 5V)
- Vgg1 should be varied between -1.0V and 0V to achieve 200mA current on the drain (Vbias).
 - Vbias may be increased to +5.5V if required to achieve greater output voltage swing.
 - Vgg2 may be adjusted between +1.5V and +0.3V to vary the output voltage swing.

Device Power Down Instructions

1. Reverse the sequence identified above in steps 1 through 4.

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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be placed as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm to 0.152 mm (3 to 6 mils).

Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

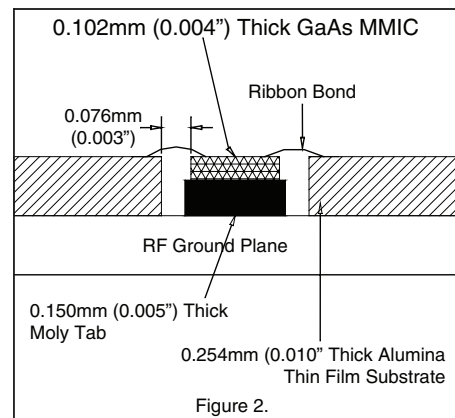
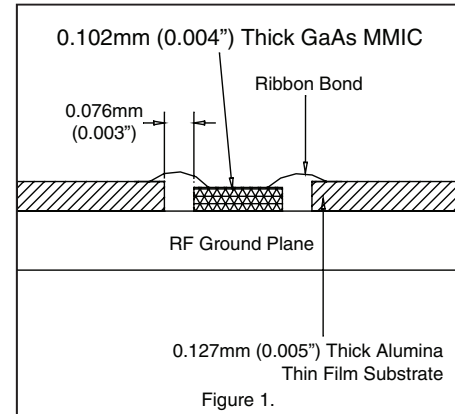
The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

RF bonds made with 0.003" x 0.0005" ribbon are recommended. These bonds should be thermosonically bonded with a force of 40-60 grams. DC bonds of 0.001" (0.025 mm) diameter, thermosonically bonded, are recommended. Ball bonds should be made with a force of 40-50 grams and wedge bonds at 18-22 grams. All bonds should be made with a nominal stage temperature of 150 °C. A minimum amount of ultrasonic energy should be applied to achieve reliable bonds. All bonds should be as short as possible, less than 12 mils (0.31 mm).



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